Sea	rch	No	tes
		,,,	



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/724,441	LEE ET AL.	
Examiner	Art Unit	
Don Williams	2878	

SEARCHED			
Class	Subclass	Date	Examiner
250	221	6/15/2006	DW
	222.1	6/15/2006	DW
	353	6/15/2006	DW
	338	6/15/2006	DW
	339.01	6/15/2006	DW
340	567	6/15/2006	DW
	555	6/15/2006	DW
	557	6/15/2006	DW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u> </u>		

(INCLUDING SEARCH	JIKAILGI	
	DATE	EXMR
East:BRS, US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB	6/15/2006	DW
Consulted with Examiner Allen of AU 2878.	6/15/2006	DW
·		